

Notice of References Cited	Application/Control No. 10/619,626	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
	Examiner Omar F. Fernández Rivas	Art Unit 2129	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,055,491	04-2000	Biliris et al.	702/176
*	B	US-5,257,364	10-1993	Melamed et al.	703/21
*	C	US-6,697,769	02-2004	Goodman et al.	703/2
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Shaw et al. "Automated Error Detection in Multibeam Bathymetry Data", IEEE ublication, 1993
	V	Burge et al "Detecting Cellular Fraud Using Adaptive Prototypes"
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.